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| <b>Searched</b><br><br> | Application/Control No.<br><br>10621449 | Applicant(s)/Patent Under<br>Reexamination<br><br>MATSUI ET AL. |
|  | Examiner<br>Rossoshek, Helen            | Art Unit<br>2825  |

| Class   | Sub Class   | Date       | Examiner |
|---------|-------------|------------|----------|
| 716     | 1,2,4,5,11  | 3/19/2005  | HR       |
| 703     | 21,23,27,28 | 3/19/2005  | HR       |
| UPDATED | UPDATED     | 11/28/2005 | HR       |

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| U.S. Patent and Trademark Office | Part of Paper No.: 11282005 |
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| <b>Search Notes</b><br><br> | Application/Control No.<br><br>10621449 | Applicant(s)/Patent Under<br>Reexamination<br><br>MATSUI ET AL. |
|  | Examiner<br>Rossoshek, Helen            | Art Unit<br>2825  |

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| EAST (USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB) | 3/19/205  | HR       |
| IEEE, AT   | 3/19/2005 | HR       |

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